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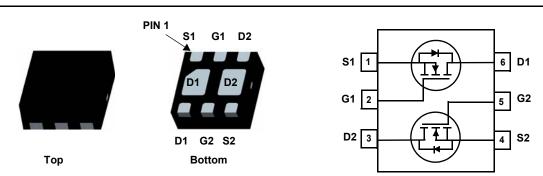


Dual N-Channel PowerTrench[®] MOSFET 30 V, 3.8 A, 68 mΩ

Features

- Max. R_{DS(on)} = 68 mΩ at V_{GS} = 4.5 V, I_D = 3.8 A
- Max. R_{DS(on)} = 88 mΩ at V_{GS} = 2.5 V, I_D = 3.4 A
- Max. R_{DS(on)} = 123 mΩ at V_{GS} = 1.8 V, I_D = 2.9 A
- Low profile 0. 8 mm maximum in the new package MicroFET 2x2 mm
- RoHS Compliant





General Description

suited to linear mode applications.

This device is designed specifically as a single package solution

for dual switching requirements in cellular handset and other

exceptional thermal performance for its physical size and is well

ultra-portable applications. It features two independent N-Channel MOSFETs with low on-state resistance for minimum

conduction losses. The MicroFET 2x2 package offers

MicroFET 2x2

MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage		30	V	
V _{GS}	Gate to Source Voltage		±12	V	
I _D	Drain Current -Continuous	(Note 1a)	3.8	٨	
	-Pulsed		16	— A	
P _D	Power Dissipation	(Note 1a)	1.5	14/	
	Power Dissipation	(Note 1b)	0.7	W	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C	

Thermal Characteristics

	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1a)	86	
$R_{ hetaJA}$	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1b)	173	
P	Thermal Resistance for Dual Operation, Junction to Ambient	ion, Junction to Ambient(Note 1b)173n, Junction to Ambient(Note 1c)69n, Junction to Ambient(Note 1d)151ion, Junction to Ambient(Note 1e)160	69	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance for Dual Operation, Junction to Ambient	(Note 1d)	151	C/vv
	Thermal Resistance for Single Operation, Junction to Ambient	(Note 1e)	160	
	Thermal Resistance for Dual Operation, Junction to Ambient	(Note 1f)	133	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
328	FDMA3028N	MicroFET 2X2	7 "	8 mm	3000 units

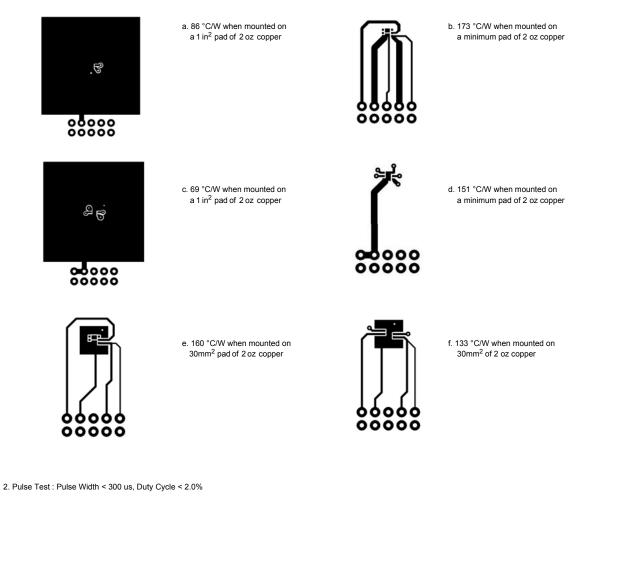
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	octeristics					
BV _{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C		23		mV/°C
DSS	Zero Gate Voltage Drain Current	V_{DS} = 24 V, V_{GS} = 0 V			1	μA
GSS	Gate to Source Leakage Current	V_{GS} = ±12 V, V_{DS} = 0 V			±100	nA
On Chara	cteristics					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \ \mu A$	0.6	0.9	1.5	V
$\Delta V_{GS(th)}$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 µA, referenced to 25 °C		-3		mV/°C
	Static Drain to Source On Resistance	V _{GS} = 4.5 V, I _D = 3.8 A		46	68	
		V _{GS} = 2.5 V, I _D = 3.4 A		56	88	mΩ
r _{DS(on)}		V _{GS} = 1.8 V, I _D = 2.9 A		80	123	
		V_{GS} = 4.5 V, I _D = 3.8 A, T _J = 125 °C		72	108	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 3.8 A		15		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz		282	375	pF
C _{oss}	Output Capacitance			40	55	pF
C _{rss}	Reverse Transfer Capacitance			29	45	pF
R _g	Gate Resistance			2.4		Ω
Switching	g Characteristics					
t _{d(on)}	Turn-On Delay	V_{DD} = 15 V, I _D = 3.8 A, V _{GS} = 4.5 V, R _{GEN} = 6 Ω		5.3	11	ns
t _r	Rise Time			3	10	ns
d(off)	Turn-Off Delay			15	27	ns
l _f	Fall Time			2.5	10	ns
Q _{g(TOT)}	Total Gate Charge			3.7	5.2	nC
Q _{gs}	Gate to Source Charge	−V _{DD} = 15 V, I _D = 3.8 A −V _{GS} = 5 V		0.4		nC
Q _{gd}	Gate to Drain "Miller" Charge	VGS UV		1		nC
	urce Diode Characteristics					
Drain-So				07	4.0	V
	Source to Drain Diode Forward Voltage	$V_{GS} = 0 V, I_S = 1.3 A$ (Note 2)		0.7	1.2	v
Drain-So V _{SD} t _{rr}	Source to Drain Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0 V, I_S = 1.3 A$ (Note 2) - $I_F = 3.8 A, di/dt = 100 A/\mu s$		0.7	1.2	ns

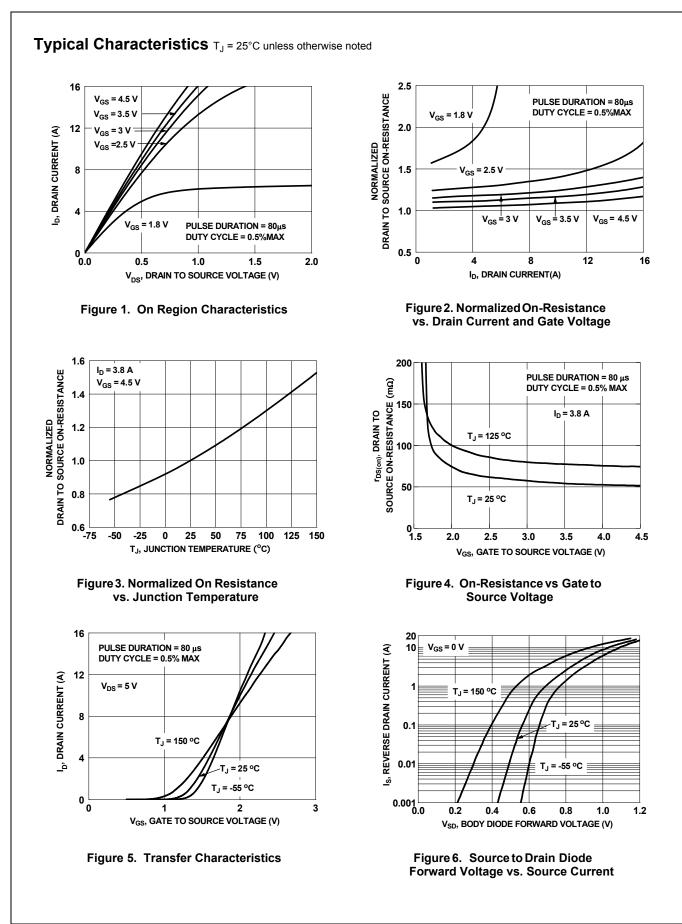
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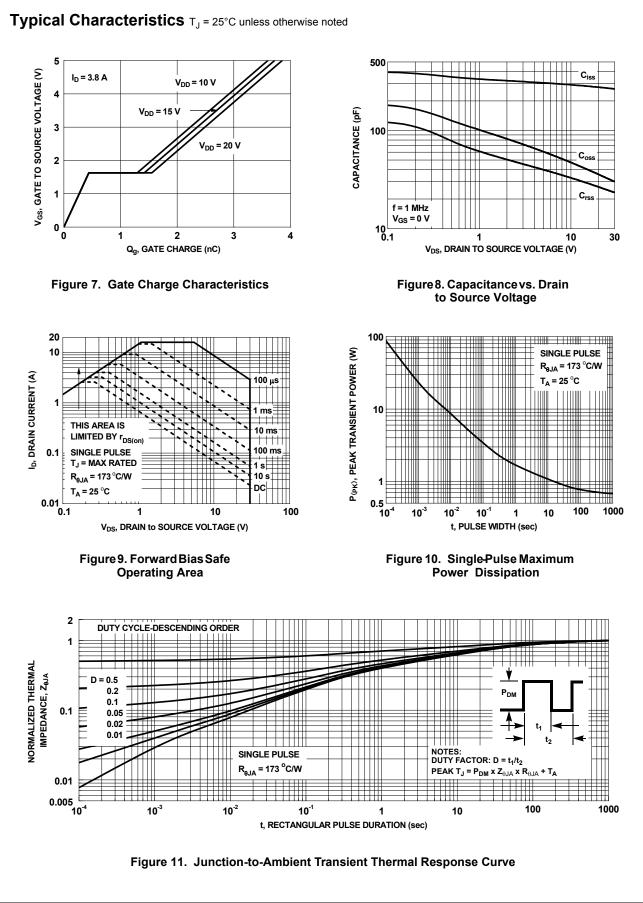
Electrical Characteristics T_J = 25 °C unless otherwise noted

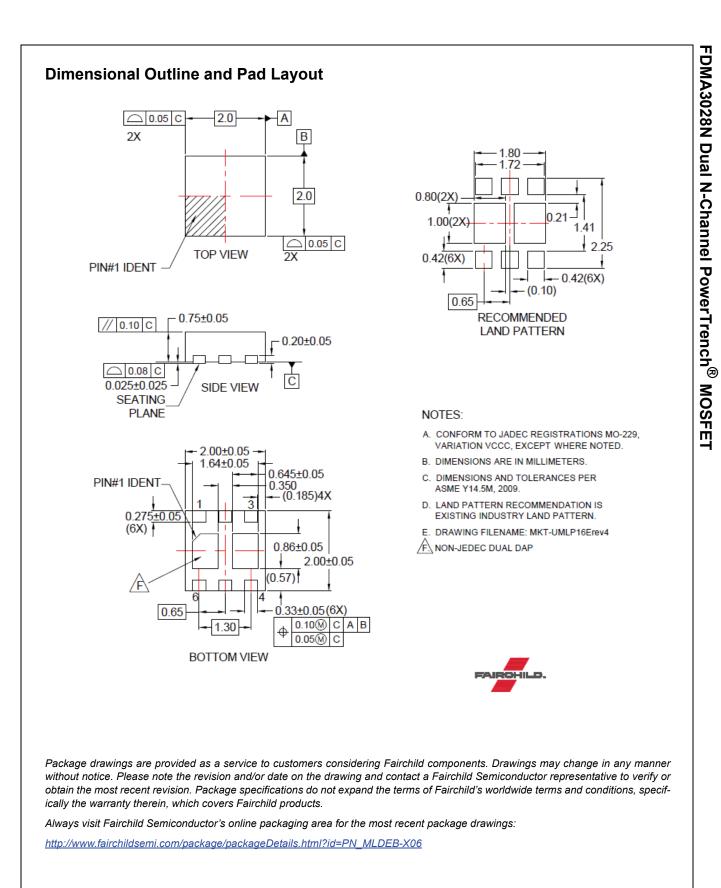
Notes:

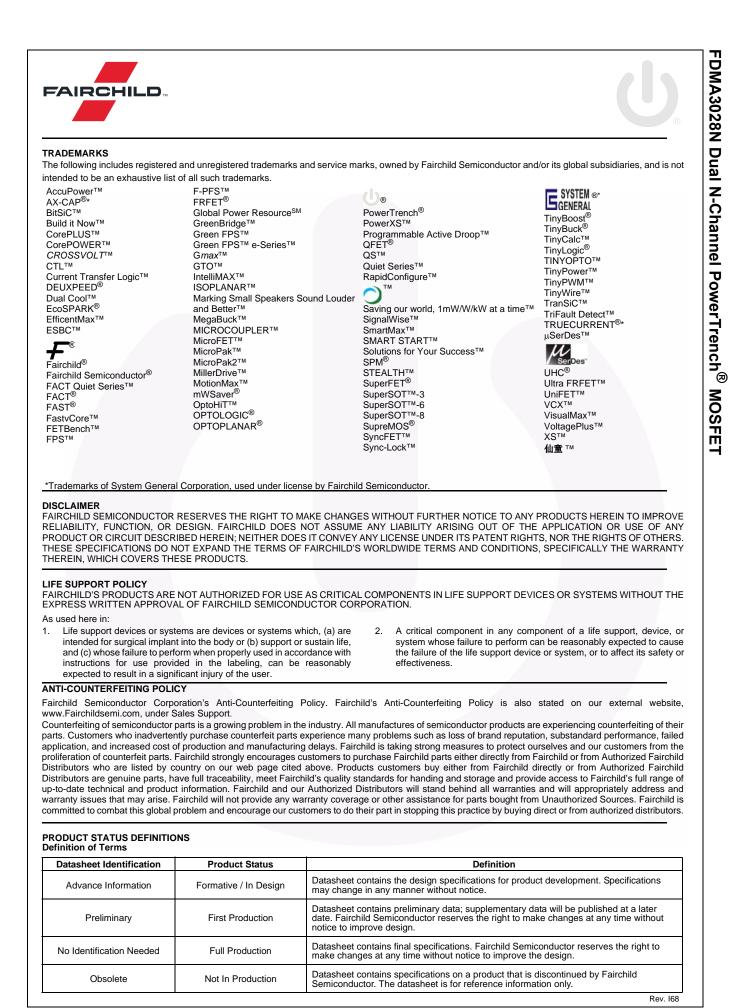
- 1. R_{0JA} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design.
- user's board design. (a) $R_{\theta JA} = 86 \text{ °C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For single operation.
 - (b) $R_{\theta JA}$ = 173 °C/W when mounted on a minimum pad of 2 oz copper. For single operation.
 - (c) $R_{0JA} = 69 \text{ }^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5 " x 1.5 " x 0.062 " thick PCB. For dual operation.
 - (d) $R_{\theta JA}$ = 151 °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.
 - (e) $R_{\theta JA}$ = 160 °C/W when mounted on a 30mm² pad of 2 oz copper. For single operation.
 - (f) $R_{\theta JA}$ = 133 $^{o}\text{C/W}$ when mounted on a 30mm² pad of 2 oz copper. For dual operation.

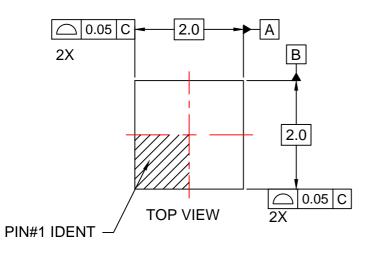


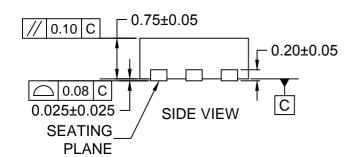


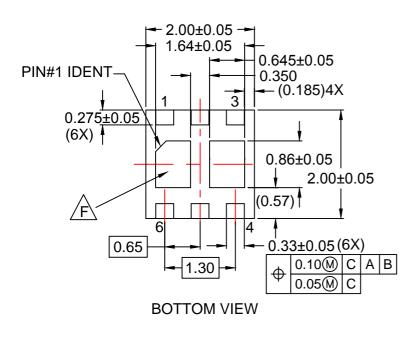


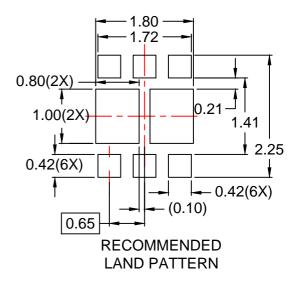












NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-UMLP16Erev4
- F. NON-JEDEC DUAL DAP



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